

# TMUX1204 5V 4:1 通用型模拟多路复用器

## 1 特性

- 轨至轨运行
- 双向信号路径
- 1.8V 逻辑兼容
- 失效防护逻辑
- 低导通电阻: 5Ω
- 宽电源电压范围: 1.08V 至 5.5V
- -40°C 至 +125°C 工作温度
- 低电源电流: 10nA
- 转换时间: 14ns
- 先断后合开关
- ESD 保护 HBM: 2000V

## 2 应用

- 模拟和数字多路复用或多路信号分离
- 电机驱动器
- 伺服驱动器控制模块
- 楼宇自动化
- 条形码扫描仪
- 模拟输入模块
- 电力输送
- 烟雾探测器
- 视频监控
- 热成像摄像机
- 电子销售终端
- 电器
- 消费类音频

## 3 说明

TMUX1204 是一款现代互补金属氧化物半导体 (CMOS) 模拟多路复用器 (MUX)，可提供 4:1 单端 (1 通道) 配置。TMUX1204 由单电源供电 (1.08V 至 5.5V)，适用于从个人电子设备到楼宇自动化系统的各种应用。低电源电流为 10nA，可用于便携式应用。

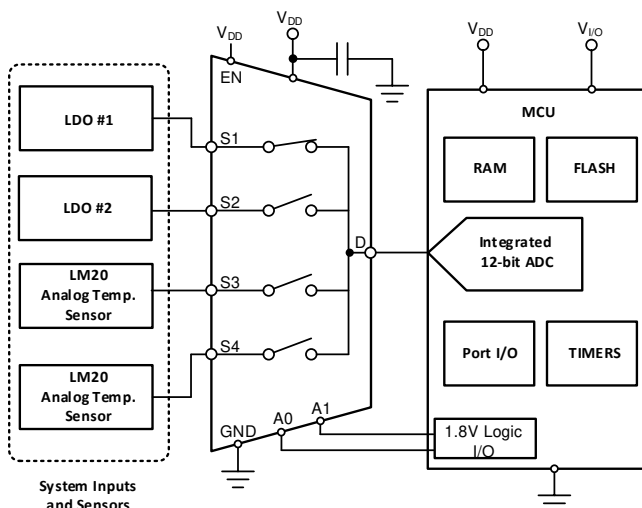
所有逻辑输入均具有兼容 1.8V 逻辑电平的阈值，当器件在有效电源电压范围内运行时，这些阈值可确保 TTL 和 CMOS 逻辑兼容性。失效防护逻辑电路允许在电源引脚之前的控制引脚上施加电压，从而保护器件免受潜在的损害。

器件信息<sup>(1)</sup>

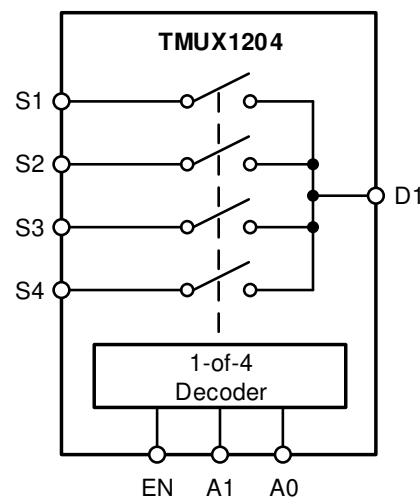
器件型号	封装	封装尺寸 (标称值)
TMUX1204	VSSOP (10) (DGS)	3.00mm × 3.00mm
	USON (10) (DQA)	2.50mm × 1.00mm

(1) 如需了解所有可用封装，请参阅数据表末尾的封装选项附录。

应用示例



TMUX1204 方框图



## 目录

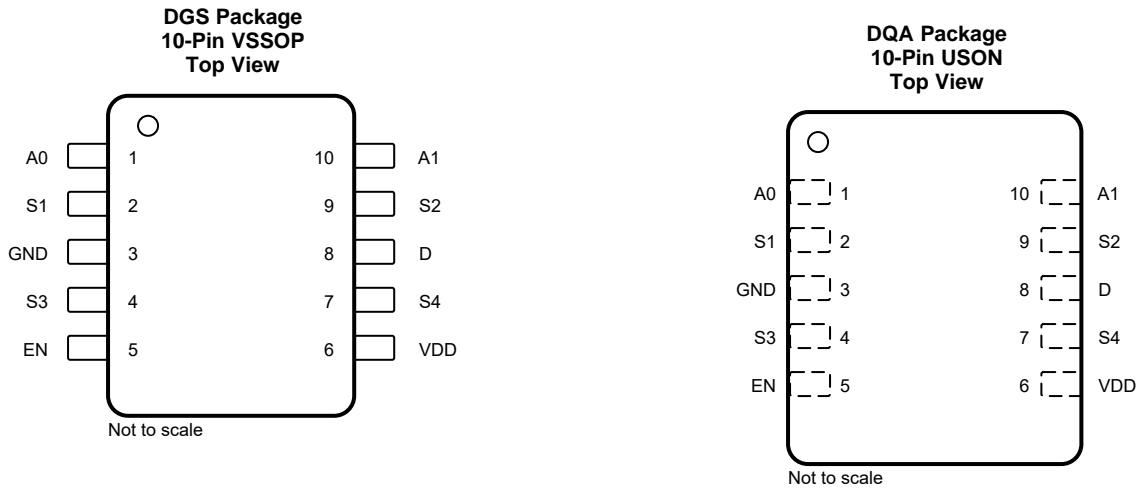
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## 4 修订历史记录

注：之前版本的页码可能与当前版本有所不同。

Changes from Original (April 2019) to Revision A	Page
• 删除了器件信息表中 DQA 封装的产品预览 .....	<b>1</b>
• Deleted Product preview from the DQA package in the <i>Pin Configuration and Functions</i> section .....	<b>3</b>
• Added Note 2 to the <i>Pin Functions</i> table .....	<b>3</b>

## 5 Pin Configuration and Functions



### Pin Functions

PIN		TYPE <sup>(1)</sup>	DESCRIPTION <sup>(2)</sup>
NAME	DGS, DQA		
A0	1	I	Address line 0. Controls the switch configuration as shown in 表 1.
S1	2	I/O	Source pin 1. Can be an input or output.
GND	3	P	Ground (0 V) reference
S3	4	I/O	Source pin 3. Can be an input or output.
EN	5	I	Active high logic enable. When this pin is low, all switches are turned off. When this pin is high, the A[1:0] logic inputs determine which switch is turned on.
VDD	6	P	Positive power supply. This pin is the most positive power-supply potential. For reliable operation, connect a decoupling capacitor ranging from 0.1 $\mu$ F to 10 $\mu$ F between V <sub>DD</sub> and GND.
S4	7	I/O	Source pin 4. Can be an input or output.
D	8	I/O	Drain pin. Can be an input or output.
S2	9	I/O	Source pin 2. Can be an input or output.
A1	10	I	Address line 1. Controls the switch configuration as shown in 表 1.

(1) I = input, O = output, I/O = input and output, P = power

(2) For unused pins, refer to the [Device Functional Modes](#)

## 6 Specifications

### 6.1 Absolute Maximum Ratings

 over operating free-air temperature range (unless otherwise noted) <sup>(1)</sup> <sup>(2)</sup> <sup>(3)</sup>

		MIN	MAX	UNIT
$V_{DD}$	Supply voltage	−0.5	6	V
$V_{SEL}$ or $V_{EN}$	Logic control input pin voltage (EN, A0, A1)	−0.5	6	V
$I_{SEL}$ or $I_{EN}$	Logic control input pin current (EN, A0, A1)	−30	30	mA
$V_S$ or $V_D$	Source or drain voltage (Sx, D)	−0.5	$V_{DD}+0.5$	V
$I_S$ or $I_D$ (CONT)	Source or drain continuous current (Sx, D)	−30	30	mA
$T_{stg}$	Storage temperature	−65	150	°C
$T_J$	Junction temperature		150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Rating* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Condition*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum.
- (3) All voltages are with respect to ground, unless otherwise specified.

### 6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>	±2000	V
		Charged device model (CDM), per JEDEC specification JESD22-C101 or ANSI/ESDA/JEDEC JS-002, all pins <sup>(2)</sup>	±750	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
$V_{DD}$	Positive power supply voltage	1.08		5.5	V
$V_S$ or $V_D$	Signal path input/output voltage (source or drain pin) (Sx, D)	0		$V_{DD}$	V
$V_{SEL}$ or $V_{EN}$	Logic control input pin voltage (EN, A0, A1)	0		5.5	V
$T_A$	Ambient temperature	−40		125	°C

### 6.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>		TMUX1204		UNIT
		DGS (VSSOP)	DQA (USON)	
		10 PINS	10 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	193.9	173.0	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	83.1	99.7	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	116.5	73.5	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	22.0	8.9	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	114.6	73.0	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	N/A	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

## 6.5 Electrical Characteristics ( $V_{DD} = 5\text{ V} \pm 10\%$ )

at  $T_A = 25^\circ\text{C}$ ,  $V_{DD} = 5\text{ V}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	TA	MIN	TYP	MAX	UNIT
ANALOG SWITCH							
R <sub>ON</sub>	On-resistance	V <sub>S</sub> = 0 V to V <sub>DD</sub> I <sub>SD</sub> = 10 mA Refer to <a href="#">On-Resistance</a>	25°C	5			Ω
			−40°C to +85°C	7		Ω	
			−40°C to +125°C	9		Ω	
ΔR <sub>ON</sub>	On-resistance matching between channels	V <sub>S</sub> = 0 V to V <sub>DD</sub> I <sub>SD</sub> = 10 mA Refer to <a href="#">On-Resistance</a>	25°C	0.15			Ω
			−40°C to +85°C	1		Ω	
			−40°C to +125°C	1		Ω	
R <sub>ON</sub> FLAT	On-resistance flatness	V <sub>S</sub> = 0 V to V <sub>DD</sub> I <sub>SD</sub> = 10 mA Refer to <a href="#">On-Resistance</a>	25°C	1.5			Ω
			−40°C to +85°C	2		Ω	
			−40°C to +125°C	3		Ω	
I <sub>S(OFF)</sub>	Source off leakage current <sup>(1)</sup>	V <sub>DD</sub> = 5 V Switch Off V <sub>D</sub> = 4.5 V / 1.5 V V <sub>S</sub> = 1.5 V / 4.5 V Refer to <a href="#">Off-Leakage Current</a>	25°C	±75			nA
			−40°C to +85°C	−150		150	nA
			−40°C to +125°C	−175		175	nA
I <sub>D(OFF)</sub>	Drain off leakage current <sup>(1)</sup>	V <sub>DD</sub> = 5 V Switch Off V <sub>D</sub> = 4.5 V / 1.5 V V <sub>S</sub> = 1.5 V / 4.5 V Refer to <a href="#">Off-Leakage Current</a>	25°C	±200			nA
			−40°C to +85°C	−500		500	nA
			−40°C to +125°C	−750		750	nA
I <sub>D(ON)</sub> I <sub>S(ON)</sub>	Channel on leakage current	V <sub>DD</sub> = 5 V Switch On V <sub>D</sub> = V <sub>S</sub> = 4.5 V / 1.5 V Refer to <a href="#">On-Leakage Current</a>	25°C	±200			nA
			−40°C to +85°C	−500		500	nA
			−40°C to +125°C	−750		750	nA
LOGIC INPUTS (EN, A0, A1)							
V <sub>IH</sub>	Input logic high		−40°C to +125°C	1.49		5.5	V
V <sub>IL</sub>	Input logic low		−40°C to +125°C	0		0.87	V
I <sub>IH</sub> I <sub>IL</sub>	Input leakage current		25°C	±0.005			μA
I <sub>IH</sub> I <sub>IL</sub>	Input leakage current		−40°C to +125°C	±0.10			μA
C <sub>IN</sub>	Logic input capacitance		25°C	1			pF
C <sub>IN</sub>	Logic input capacitance		−40°C to +125°C			2	pF
POWER SUPPLY							
I <sub>DD</sub>	V <sub>DD</sub> supply current	Logic inputs = 0 V or 5.5 V	25°C	0.01			μA
			−40°C to +125°C	2		μA	

(1) When  $V_S$  is 4.5 V,  $V_D$  is 1.5 V or when  $V_S$  is 1.5 V,  $V_D$  is 4.5 V.

**Electrical Characteristics ( $V_{DD} = 5\text{ V} \pm 10\%$ ) (continued)**

 at  $T_A = 25^\circ\text{C}$ ,  $V_{DD} = 5\text{ V}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	TA	MIN	TYP	MAX	UNIT
<b>DYNAMIC CHARACTERISTICS</b>							
$t_{\text{TRAN}}$	Transition time between channels	$V_S = 3\text{ V}$ $R_L = 200\ \Omega$ , $C_L = 15\text{ pF}$ Refer to <a href="#">Transition Time</a>	$25^\circ\text{C}$		14		ns
			$-40^\circ\text{C}$ to $+85^\circ\text{C}$			21	ns
			$-40^\circ\text{C}$ to $+125^\circ\text{C}$			22	ns
$t_{\text{OPEN}}$ (BBM)	Break before make time	$V_S = 3\text{ V}$ $R_L = 200\ \Omega$ , $C_L = 15\text{ pF}$ Refer to <a href="#">Break-Before-Make</a>	$25^\circ\text{C}$		8		ns
			$-40^\circ\text{C}$ to $+85^\circ\text{C}$	1			ns
			$-40^\circ\text{C}$ to $+125^\circ\text{C}$	1			ns
$t_{\text{ON(EN)}}$	Enable turn-on time	$V_S = 3\text{ V}$ $R_L = 200\ \Omega$ , $C_L = 15\text{ pF}$ Refer to $t_{\text{ON(EN)}}$ and $t_{\text{OFF(EN)}}$	$25^\circ\text{C}$		14		ns
			$-40^\circ\text{C}$ to $+85^\circ\text{C}$			20	ns
			$-40^\circ\text{C}$ to $+125^\circ\text{C}$			20	ns
$t_{\text{OFF(EN)}}$	Enable turn-off time	$V_S = 3\text{ V}$ $R_L = 200\ \Omega$ , $C_L = 15\text{ pF}$ Refer to $t_{\text{ON(EN)}}$ and $t_{\text{OFF(EN)}}$	$25^\circ\text{C}$		5		ns
			$-40^\circ\text{C}$ to $+85^\circ\text{C}$			20	ns
			$-40^\circ\text{C}$ to $+125^\circ\text{C}$			20	ns
$Q_C$	Charge Injection	$V_S = 1\text{ V}$ $R_S = 0\ \Omega$ , $C_L = 1\text{ nF}$ Refer to <a href="#">Charge Injection</a>	$25^\circ\text{C}$		$\pm 9$		pC
$O_{\text{ISO}}$	Off Isolation	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $f = 1\text{ MHz}$ Refer to <a href="#">Off Isolation</a>	$25^\circ\text{C}$		-62		dB
		$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $f = 10\text{ MHz}$ Refer to <a href="#">Off Isolation</a>	$25^\circ\text{C}$		-42		dB
$X_{\text{TALK}}$	Crosstalk	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $f = 1\text{ MHz}$ Refer to <a href="#">Crosstalk</a>	$25^\circ\text{C}$		-62		dB
		$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $f = 10\text{ MHz}$ Refer to <a href="#">Crosstalk</a>	$25^\circ\text{C}$		-42		dB
BW	Bandwidth	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ Refer to <a href="#">Bandwidth</a>	$25^\circ\text{C}$		125		MHz
$C_{\text{SOFF}}$	Source off capacitance	$f = 1\text{ MHz}$	$25^\circ\text{C}$		13		pF
$C_{\text{DOFF}}$	Drain off capacitance	$f = 1\text{ MHz}$	$25^\circ\text{C}$		38		pF
$C_{\text{SON}}$ $C_{\text{DON}}$	On capacitance	$f = 1\text{ MHz}$	$25^\circ\text{C}$		42		pF

## 6.6 Electrical Characteristics ( $V_{DD} = 3.3 \text{ V} \pm 10 \%$ )

at  $T_A = 25^\circ\text{C}$ ,  $V_{DD} = 3.3 \text{ V}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	TA	MIN	TYP	MAX	UNIT
ANALOG SWITCH							
R <sub>ON</sub>	On-resistance	V <sub>S</sub> = 0 V to V <sub>DD</sub> I <sub>SD</sub> = 10 mA Refer to <a href="#">On-Resistance</a>	25°C	9			Ω
			−40°C to +85°C	15		Ω	
			−40°C to +125°C	17		Ω	
ΔR <sub>ON</sub>	On-resistance matching between channels	V <sub>S</sub> = 0 V to V <sub>DD</sub> I <sub>SD</sub> = 10 mA Refer to <a href="#">On-Resistance</a>	25°C	0.15			Ω
			−40°C to +85°C	1		Ω	
			−40°C to +125°C	1		Ω	
R <sub>ON</sub> FLAT	On-resistance flatness	V <sub>S</sub> = 0 V to V <sub>DD</sub> I <sub>SD</sub> = 10 mA Refer to <a href="#">On-Resistance</a>	25°C	3			Ω
			−40°C to +85°C	5		Ω	
			−40°C to +125°C	6		Ω	
I <sub>S(OFF)</sub>	Source off leakage current <sup>(1)</sup>	V <sub>DD</sub> = 3.3 V Switch Off V <sub>D</sub> = 3 V / 1 V V <sub>S</sub> = 1 V / 3 V Refer to <a href="#">Off-Leakage Current</a>	25°C	±75			nA
			−40°C to +85°C	−150	150	nA	
			−40°C to +125°C	−175	175	nA	
I <sub>D(OFF)</sub>	Drain off leakage current <sup>(1)</sup>	V <sub>DD</sub> = 3.3 V Switch Off V <sub>D</sub> = 3 V / 1 V V <sub>S</sub> = 1 V / 3 V Refer to <a href="#">Off-Leakage Current</a>	25°C	±200			nA
			−40°C to +85°C	−500	500	nA	
			−40°C to +125°C	−750	750	nA	
I <sub>D(ON)</sub> I <sub>S(ON)</sub>	Channel on leakage current	V <sub>DD</sub> = 3.3 V Switch On V <sub>D</sub> = V <sub>S</sub> = 3 V / 1 V Refer to <a href="#">On-Leakage Current</a>	25°C	±200			nA
			−40°C to +85°C	−500	500	nA	
			−40°C to +125°C	−750	750	nA	
LOGIC INPUTS (EN, A0, A1)							
V <sub>IH</sub>	Input logic high		−40°C to +125°C	1.35		5.5	V
V <sub>IL</sub>	Input logic low		−40°C to +125°C	0		0.8	V
I <sub>IH</sub> I <sub>IL</sub>	Input leakage current		25°C	±0.005			μA
I <sub>IH</sub> I <sub>IL</sub>	Input leakage current		−40°C to +125°C	±0.10			μA
C <sub>IN</sub>	Logic input capacitance		25°C	1			pF
C <sub>IN</sub>	Logic input capacitance		−40°C to +125°C			2	pF
POWER SUPPLY							
I <sub>DD</sub>	V <sub>DD</sub> supply current	Logic inputs = 0 V or 5.5 V	25°C	0.01			μA
			−40°C to +125°C	1.3		μA	

(1) When  $V_S$  is 3 V,  $V_D$  is 1 V or when  $V_S$  is 1 V,  $V_D$  is 3 V.

**Electrical Characteristics ( $V_{DD} = 3.3\text{ V} \pm 10\%$ ) (continued)**

 at  $T_A = 25^\circ\text{C}$ ,  $V_{DD} = 3.3\text{ V}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	TA	MIN	TYP	MAX	UNIT
<b>DYNAMIC CHARACTERISTICS</b>							
$t_{\text{TRAN}}$	Transition time between channels	$V_S = 2\text{ V}$ $R_L = 200\ \Omega$ , $C_L = 15\text{ pF}$ Refer to <a href="#">Transition Time</a>	$25^\circ\text{C}$		14		ns
			$-40^\circ\text{C}$ to $+85^\circ\text{C}$			25	ns
			$-40^\circ\text{C}$ to $+125^\circ\text{C}$			25	ns
$t_{\text{OPEN}}$ (BBM)	Break before make time	$V_S = 2\text{ V}$ $R_L = 200\ \Omega$ , $C_L = 15\text{ pF}$ Refer to <a href="#">Break-Before-Make</a>	$25^\circ\text{C}$		8		ns
			$-40^\circ\text{C}$ to $+85^\circ\text{C}$	1			ns
			$-40^\circ\text{C}$ to $+125^\circ\text{C}$	1			ns
$t_{\text{ON(EN)}}$	Enable turn-on time	$V_S = 2\text{ V}$ $R_L = 200\ \Omega$ , $C_L = 15\text{ pF}$ Refer to $t_{\text{ON(EN)}}$ and $t_{\text{OFF(EN)}}$	$25^\circ\text{C}$		14		ns
			$-40^\circ\text{C}$ to $+85^\circ\text{C}$			25	ns
			$-40^\circ\text{C}$ to $+125^\circ\text{C}$			25	ns
$t_{\text{OFF(EN)}}$	Enable turn-off time	$V_S = 2\text{ V}$ $R_L = 200\ \Omega$ , $C_L = 15\text{ pF}$ Refer to $t_{\text{ON(EN)}}$ and $t_{\text{OFF(EN)}}$	$25^\circ\text{C}$		7		ns
			$-40^\circ\text{C}$ to $+85^\circ\text{C}$			13	ns
			$-40^\circ\text{C}$ to $+125^\circ\text{C}$			13	ns
$Q_C$	Charge Injection	$V_S = 1\text{ V}$ $R_S = 0\ \Omega$ , $C_L = 1\text{ nF}$ Refer to <a href="#">Charge Injection</a>	$25^\circ\text{C}$		$\pm 7$		pC
$O_{\text{ISO}}$	Off Isolation	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $f = 1\text{ MHz}$ Refer to <a href="#">Off Isolation</a>	$25^\circ\text{C}$		-62		dB
		$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $f = 10\text{ MHz}$ Refer to <a href="#">Off Isolation</a>	$25^\circ\text{C}$		-42		dB
$X_{\text{TALK}}$	Crosstalk	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $f = 1\text{ MHz}$ Refer to <a href="#">Crosstalk</a>	$25^\circ\text{C}$		-62		dB
		$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $f = 10\text{ MHz}$ Refer to <a href="#">Crosstalk</a>	$25^\circ\text{C}$		-42		dB
BW	Bandwidth	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ Refer to <a href="#">Bandwidth</a>	$25^\circ\text{C}$		125		MHz
$C_{\text{SOFF}}$	Source off capacitance	$f = 1\text{ MHz}$	$25^\circ\text{C}$		13		pF
$C_{\text{DOFF}}$	Drain off capacitance	$f = 1\text{ MHz}$	$25^\circ\text{C}$		38		pF
$C_{\text{SON}}$ $C_{\text{DON}}$	On capacitance	$f = 1\text{ MHz}$	$25^\circ\text{C}$		42		pF



## 6.7 Electrical Characteristics ( $V_{DD} = 1.8 \text{ V} \pm 10 \%$ )

at  $T_A = 25^\circ\text{C}$ ,  $V_{DD} = 1.8 \text{ V}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	TA	MIN	TYP	MAX	UNIT
ANALOG SWITCH							
R <sub>ON</sub>	On-resistance	V <sub>S</sub> = 0 V to V <sub>DD</sub> I <sub>SD</sub> = 10 mA Refer to <a href="#">On-Resistance</a>	25°C	40			Ω
			−40°C to +85°C		80	Ω	
			−40°C to +125°C		80	Ω	
ΔR <sub>ON</sub>	On-resistance matching between channels	V <sub>S</sub> = 0 V to V <sub>DD</sub> I <sub>SD</sub> = 10 mA Refer to <a href="#">On-Resistance</a>	25°C	0.15			Ω
			−40°C to +85°C		1.5	Ω	
			−40°C to +125°C		1.5	Ω	
I <sub>S(OFF)</sub>	Source off leakage current <sup>(1)</sup>	V <sub>DD</sub> = 1.98 V Switch Off V <sub>D</sub> = 1.8 V / 1 V V <sub>S</sub> = 1 V / 1.8 V Refer to <a href="#">Off-Leakage Current</a>	25°C	±75			nA
			−40°C to +85°C	−150	150	nA	
			−40°C to +125°C	−175	175	nA	
I <sub>D(OFF)</sub>	Drain off leakage current <sup>(1)</sup>	V <sub>DD</sub> = 1.98 V Switch Off V <sub>D</sub> = 1.8 V / 1 V V <sub>S</sub> = 1 V / 1.8 V Refer to <a href="#">Off-Leakage Current</a>	25°C	±200			nA
			−40°C to +85°C	−500	500	nA	
			−40°C to +125°C	−750	750	nA	
I <sub>D(ON)</sub> I <sub>S(ON)</sub>	Channel on leakage current	V <sub>DD</sub> = 1.98 V Switch On V <sub>D</sub> = V <sub>S</sub> = 1.8 V / 1 V Refer to <a href="#">On-Leakage Current</a>	25°C	±200			nA
			−40°C to +85°C	−500	500	nA	
			−40°C to +125°C	−750	750	nA	
LOGIC INPUTS (EN, A0, A1)							
V <sub>IH</sub>	Input logic high		−40°C to +125°C	1.07		5.5	V
V <sub>IL</sub>	Input logic low		−40°C to +125°C	0		0.68	V
I <sub>IH</sub> I <sub>IL</sub>	Input leakage current		25°C	±0.005			μA
I <sub>IH</sub> I <sub>IL</sub>	Input leakage current		−40°C to +125°C	±0.10			μA
C <sub>IN</sub>	Logic input capacitance		25°C	1			pF
C <sub>IN</sub>	Logic input capacitance		−40°C to +125°C			2	pF
POWER SUPPLY							
I <sub>DD</sub>	V <sub>DD</sub> supply current	Logic inputs = 0 V or 5.5 V	25°C	0.005			μA
			−40°C to +125°C			0.95	μA

(1) When  $V_S$  is 1.8 V,  $V_D$  is 1 V or when  $V_S$  is 1 V,  $V_D$  is 1.8 V.

**Electrical Characteristics ( $V_{DD} = 1.8\text{ V} \pm 10\%$ ) (continued)**

 at  $T_A = 25^\circ\text{C}$ ,  $V_{DD} = 1.8\text{ V}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	TA	MIN	TYP	MAX	UNIT
<b>DYNAMIC CHARACTERISTICS</b>							
$t_{\text{TRAN}}$	Transition time between channels	$V_S = 1\text{ V}$ $R_L = 200\ \Omega$ , $C_L = 15\text{ pF}$ Refer to <a href="#">Transition Time</a>	$25^\circ\text{C}$		28		ns
			$-40^\circ\text{C}$ to $+85^\circ\text{C}$			48	ns
			$-40^\circ\text{C}$ to $+125^\circ\text{C}$			48	ns
$t_{\text{OPEN}}$ (BBM)	Break before make time	$V_S = 1\text{ V}$ $R_L = 200\ \Omega$ , $C_L = 15\text{ pF}$ Refer to <a href="#">Break-Before-Make</a>	$25^\circ\text{C}$		16		ns
			$-40^\circ\text{C}$ to $+85^\circ\text{C}$	1			ns
			$-40^\circ\text{C}$ to $+125^\circ\text{C}$	1			ns
$t_{\text{ON(EN)}}$	Enable turn-on time	$V_S = 1\text{ V}$ $R_L = 200\ \Omega$ , $C_L = 15\text{ pF}$ Refer to <a href="#">t<sub>ON(EN)</sub></a> and <a href="#">t<sub>OFF(EN)</sub></a>	$25^\circ\text{C}$		28		ns
			$-40^\circ\text{C}$ to $+85^\circ\text{C}$			48	ns
			$-40^\circ\text{C}$ to $+125^\circ\text{C}$			48	ns
$t_{\text{OFF(EN)}}$	Enable turn-off time	$V_S = 1\text{ V}$ $R_L = 200\ \Omega$ , $C_L = 15\text{ pF}$ Refer to <a href="#">t<sub>ON(EN)</sub></a> and <a href="#">t<sub>OFF(EN)</sub></a>	$25^\circ\text{C}$		16		ns
			$-40^\circ\text{C}$ to $+85^\circ\text{C}$			27	ns
			$-40^\circ\text{C}$ to $+125^\circ\text{C}$			27	ns
$Q_C$	Charge Injection	$V_S = 1\text{ V}$ $R_S = 0\ \Omega$ , $C_L = 1\text{ nF}$ Refer to <a href="#">Charge Injection</a>	$25^\circ\text{C}$		–2		pC
$O_{\text{ISO}}$	Off Isolation	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $f = 1\text{ MHz}$ Refer to <a href="#">Off Isolation</a>	$25^\circ\text{C}$		–62		dB
		$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $f = 10\text{ MHz}$ Refer to <a href="#">Off Isolation</a>	$25^\circ\text{C}$		–42		dB
$X_{\text{TALK}}$	Crosstalk	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $f = 1\text{ MHz}$ Refer to <a href="#">Crosstalk</a>	$25^\circ\text{C}$		–62		dB
		$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $f = 10\text{ MHz}$ Refer to <a href="#">Crosstalk</a>	$25^\circ\text{C}$		–42		dB
BW	Bandwidth	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ Refer to <a href="#">Bandwidth</a>	$25^\circ\text{C}$		125		MHz
$C_{\text{SOFF}}$	Source off capacitance	$f = 1\text{ MHz}$	$25^\circ\text{C}$		13		pF
$C_{\text{DOFF}}$	Drain off capacitance	$f = 1\text{ MHz}$	$25^\circ\text{C}$		38		pF
$C_{\text{SON}}$ $C_{\text{DON}}$	On capacitance	$f = 1\text{ MHz}$	$25^\circ\text{C}$		42		pF

## 6.8 Electrical Characteristics ( $V_{DD} = 1.2 \text{ V} \pm 10 \%$ )

PARAMETER		TEST CONDITIONS	TA	MIN	TYP	MAX	UNIT
ANALOG SWITCH							
R <sub>ON</sub>	On-resistance	V <sub>S</sub> = 0 V to V <sub>DD</sub> I <sub>SD</sub> = 10 mA Refer to <a href="#">On-Resistance</a>	25°C	70			Ω
			−40°C to +85°C			105	Ω
			−40°C to +125°C			105	Ω
ΔR <sub>ON</sub>	On-resistance matching between channels	V <sub>S</sub> = 0 V to V <sub>DD</sub> I <sub>SD</sub> = 10 mA Refer to <a href="#">On-Resistance</a>	25°C	0.15			Ω
			−40°C to +85°C			1.5	Ω
			−40°C to +125°C			1.5	Ω
I <sub>S(OFF)</sub>	Source off leakage current <sup>(1)</sup>	V <sub>DD</sub> = 1.32 V Switch Off V <sub>D</sub> = 1.2 V / 1 V V <sub>S</sub> = 1 V / 1.2 V Refer to <a href="#">Off-Leakage Current</a>	25°C	±75			nA
			−40°C to +85°C	−150		150	nA
			−40°C to +125°C	−175		175	nA
I <sub>D(OFF)</sub>	Drain off leakage current <sup>(1)</sup>	V <sub>DD</sub> = 1.32 V Switch Off V <sub>D</sub> = 1.2 V / 1 V V <sub>S</sub> = 1 V / 1.2 V Refer to <a href="#">Off-Leakage Current</a>	25°C	±200			nA
			−40°C to +85°C	−500		500	nA
			−40°C to +125°C	−750		750	nA
I <sub>D(ON)</sub> I <sub>S(ON)</sub>	Channel on leakage current	V <sub>DD</sub> = 1.32 V Switch On V <sub>D</sub> = V <sub>S</sub> = 1.2 V / 1 V Refer to <a href="#">On-Leakage Current</a>	25°C	±200			nA
			−40°C to +85°C	−500		500	nA
			−40°C to +125°C	−750		750	nA
LOGIC INPUTS (EN, A0, A1)							
V <sub>IH</sub>	Input logic high		−40°C to +125°C	0.96		5.5	V
V <sub>IL</sub>	Input logic low		−40°C to +125°C	0		0.36	V
I <sub>IH</sub> I <sub>IL</sub>	Input leakage current		25°C	±0.005			μA
I <sub>IH</sub> I <sub>IL</sub>	Input leakage current		−40°C to +125°C	±0.10			μA
C <sub>IN</sub>	Logic input capacitance		25°C	1			pF
C <sub>IN</sub>	Logic input capacitance		−40°C to +125°C			2	pF
POWER SUPPLY							
I <sub>DD</sub>	V <sub>DD</sub> supply current	Logic inputs = 0 V or 5.5 V	25°C	0.005			μA
			−40°C to +125°C			0.8	μA

(1) When  $V_S$  is 1 V,  $V_D$  is 1.2 V or when  $V_S$  is 1.2 V,  $V_D$  is 1 V.

**Electrical Characteristics ( $V_{DD} = 1.2\text{ V} \pm 10\%$ ) (continued)**

PARAMETER		TEST CONDITIONS	TA	MIN	TYP	MAX	UNIT
<b>DYNAMIC CHARACTERISTICS</b>							
$t_{\text{TRAN}}$	Transition time between channels	$V_S = 1\text{ V}$ $R_L = 200\ \Omega$ , $C_L = 15\text{ pF}$ Refer to <a href="#">Transition Time</a>	25°C		60		ns
			–40°C to +85°C			210	ns
			–40°C to +125°C			210	ns
$t_{\text{OPEN}}$ (BBM)	Break before make time	$V_S = 1\text{ V}$ $R_L = 200\ \Omega$ , $C_L = 15\text{ pF}$ Refer to <a href="#">Break-Before-Make</a>	25°C		28		ns
			–40°C to +85°C	1			ns
			–40°C to +125°C	1			ns
$t_{\text{ON(EN)}}$	Enable turn-on time	$V_S = 1\text{ V}$ $R_L = 200\ \Omega$ , $C_L = 15\text{ pF}$ Refer to $t_{\text{ON(EN)}}$ and $t_{\text{OFF(EN)}}$	25°C		60		ns
			–40°C to +85°C			190	ns
			–40°C to +125°C			190	ns
$t_{\text{OFF(EN)}}$	Enable turn-off time	$V_S = 1\text{ V}$ $R_L = 200\ \Omega$ , $C_L = 15\text{ pF}$ Refer to $t_{\text{ON(EN)}}$ and $t_{\text{OFF(EN)}}$	25°C		45		ns
			–40°C to +85°C			150	ns
			–40°C to +125°C			150	ns
$Q_C$	Charge Injection	$V_S = 1\text{ V}$ $R_S = 0\ \Omega$ , $C_L = 1\text{ nF}$ Refer to <a href="#">Charge Injection</a>	25°C		±2		pC
$O_{\text{ISO}}$	Off Isolation	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $f = 1\text{ MHz}$ Refer to <a href="#">Off Isolation</a>	25°C		–62		dB
		$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $f = 10\text{ MHz}$ Refer to <a href="#">Off Isolation</a>	25°C		–42		dB
$X_{\text{TALK}}$	Crosstalk	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $f = 1\text{ MHz}$ Refer to <a href="#">Crosstalk</a>	25°C		–62		dB
		$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $f = 10\text{ MHz}$ Refer to <a href="#">Crosstalk</a>	25°C		–42		dB
BW	Bandwidth	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ Refer to <a href="#">Bandwidth</a>	25°C		125		MHz
$C_{\text{SOFF}}$	Source off capacitance	$f = 1\text{ MHz}$	25°C		13		pF
$C_{\text{DOFF}}$	Drain off capacitance	$f = 1\text{ MHz}$	25°C		38		pF
$C_{\text{SON}}$ $C_{\text{DON}}$	On capacitance	$f = 1\text{ MHz}$	25°C		42		pF

## 6.9 Typical Characteristics

at  $T_A = 25^\circ\text{C}$ ,  $V_{DD} = 5\text{ V}$  (unless otherwise noted)

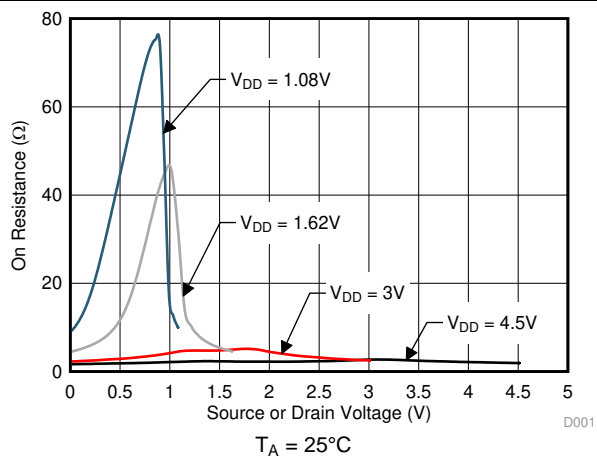


图 1. On-Resistance vs Source or Drain Voltage

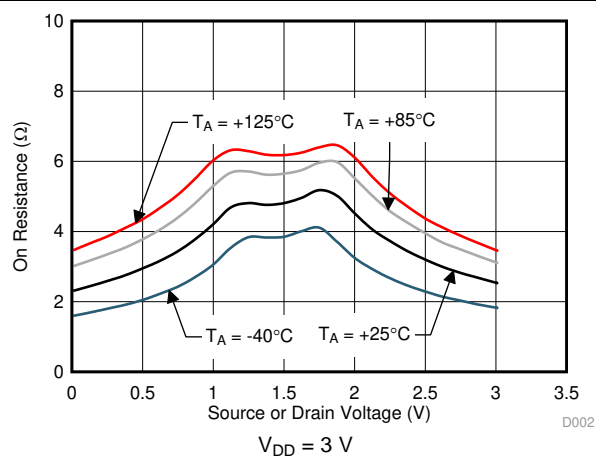


图 2. On-Resistance vs Source or Drain Voltage

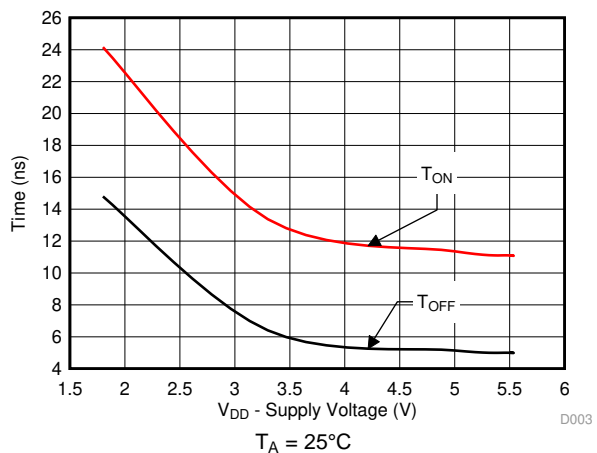


图 3.  $T_{ON}$  (EN) and  $T_{OFF}$  (EN) vs Supply Voltage

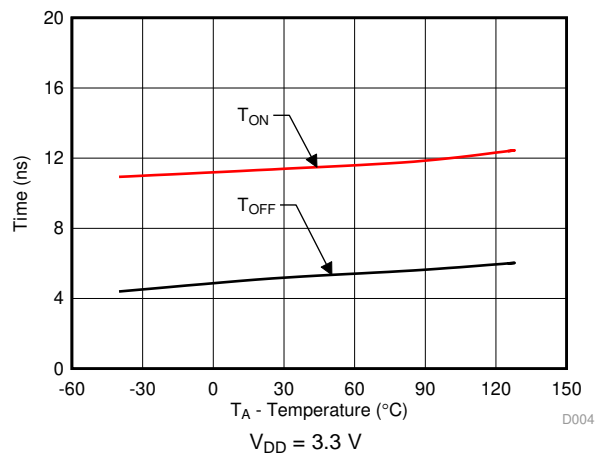


图 4.  $T_{ON}$  (EN) and  $T_{OFF}$  (EN) vs Temperature

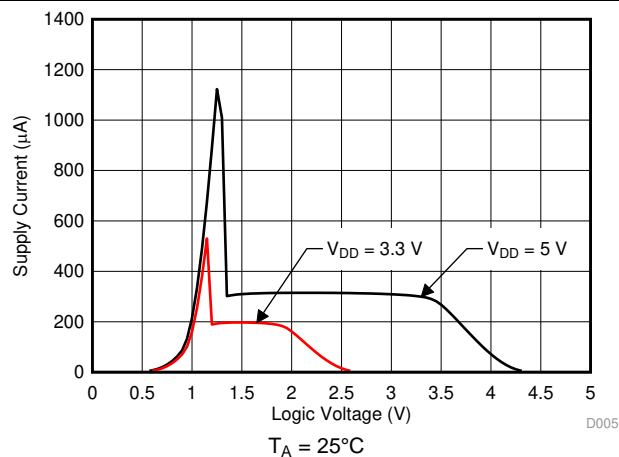


图 5. Supply Current vs Logic Voltage

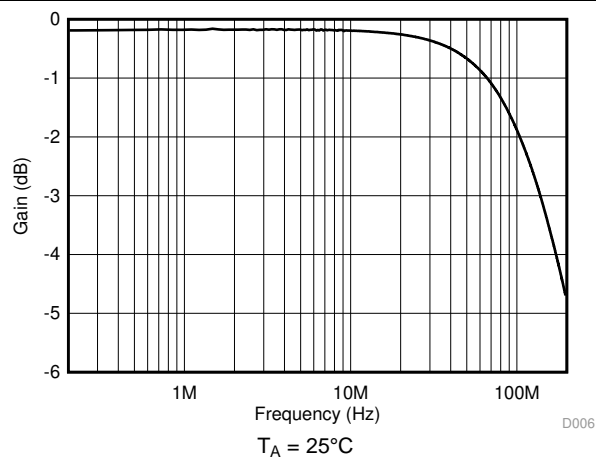


图 6. Frequency Response

## 7 Parameter Measurement Information

### 7.1 On-Resistance

The on-resistance of a device is the ohmic resistance between the source (Sx) and drain (D) pins of the device. The on-resistance varies with input voltage and supply voltage. The symbol  $R_{ON}$  is used to denote on-resistance. The measurement setup used to measure  $R_{ON}$  is shown in 图 7. Voltage (V) and current ( $I_{SD}$ ) are measured using this setup, and  $R_{ON}$  is computed with  $R_{ON} = V / I_{SD}$ :

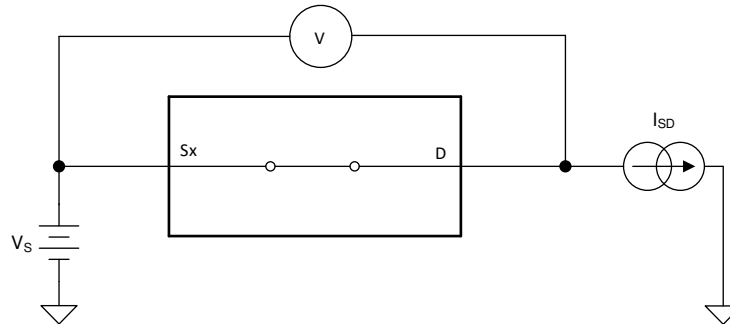


图 7. On-Resistance Measurement Setup

### 7.2 Off-Leakage Current

There are two types of leakage currents associated with a switch during the off state:

1. Source off-leakage current
2. Drain off-leakage current

Source leakage current is defined as the leakage current flowing into or out of the source pin when the switch is off. This current is denoted by the symbol  $I_{S(OFF)}$ .

Drain leakage current is defined as the leakage current flowing into or out of the drain pin when the switch is off. This current is denoted by the symbol  $I_{D(OFF)}$ .

The setup used to measure both off-leakage currents is shown in 图 8.

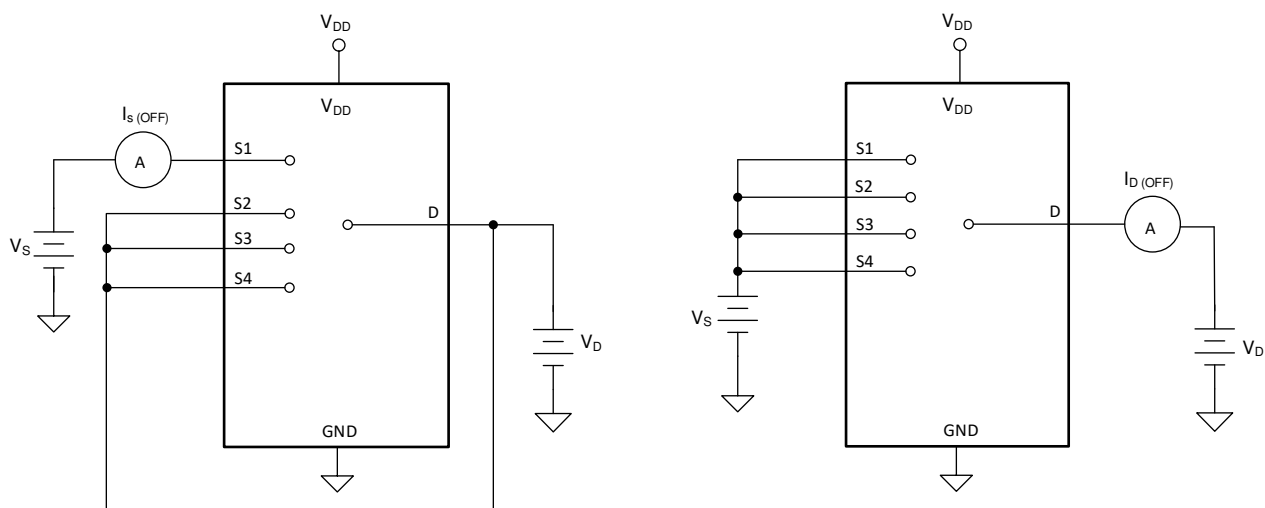


图 8. Off-Leakage Measurement Setup

### 7.3 On-Leakage Current

Source on-leakage current is defined as the leakage current flowing into or out of the source pin when the switch is on. This current is denoted by the symbol  $I_{S(ON)}$ .

Drain on-leakage current is defined as the leakage current flowing into or out of the drain pin when the switch is on. This current is denoted by the symbol  $I_{D(ON)}$ .

Either the source pin or drain pin is left floating during the measurement. 图 9 shows the circuit used for measuring the on-leakage current, denoted by  $I_{S(ON)}$  or  $I_{D(ON)}$ .

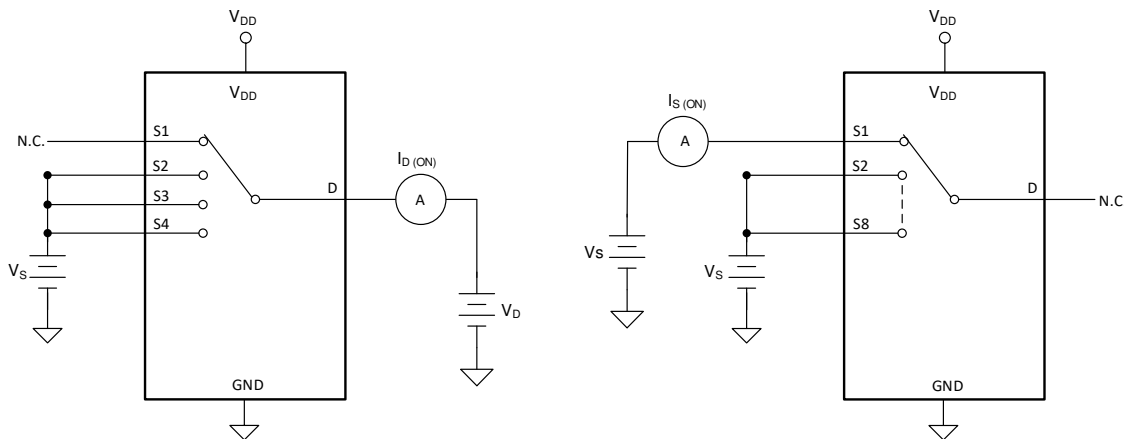


图 9. On-Leakage Measurement Setup

### 7.4 Transition Time

Transition time is defined as the time taken by the output of the device to rise or fall 10% after the address signal has risen or fallen past the logic threshold. The 10% transition measurement is utilized to provide the timing of the device. System level timing can then account for the time constant added from the load resistance and load capacitance. 图 10 shows the setup used to measure transition time, denoted by the symbol  $t_{\text{TRANSITION}}$ .

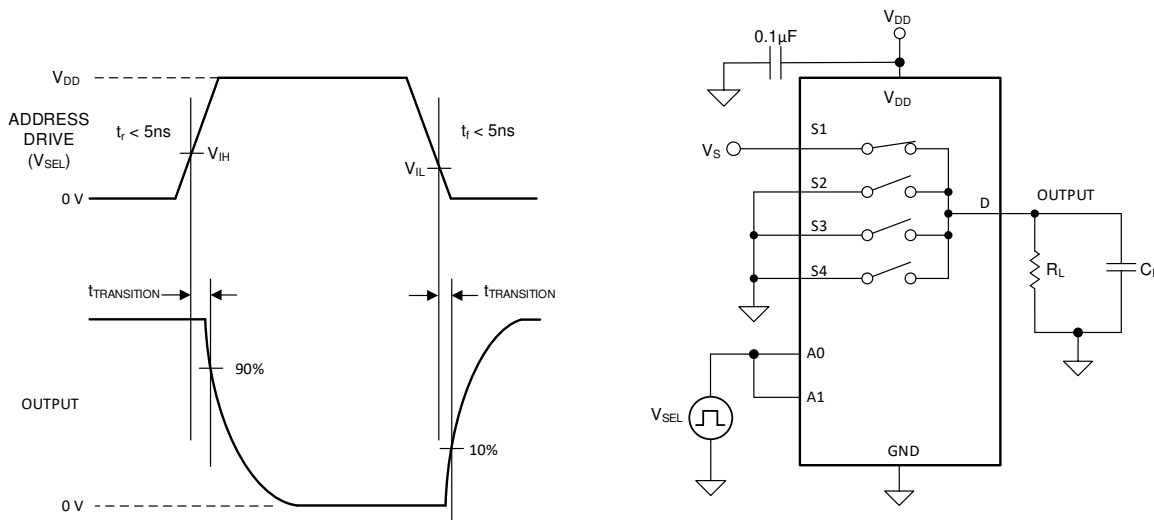


图 10. Transition-Time Measurement Setup

## 7.5 Break-Before-Make

Break-before-make delay is a safety feature that prevents two inputs from connecting when the device is switching. The output first breaks from the on-state switch before making the connection with the next on-state switch. The time delay between the *break* and the *make* is known as break-before-make delay. 图 11 shows the setup used to measure break-before-make delay, denoted by the symbol  $t_{\text{OPEN(BBM)}}$ .

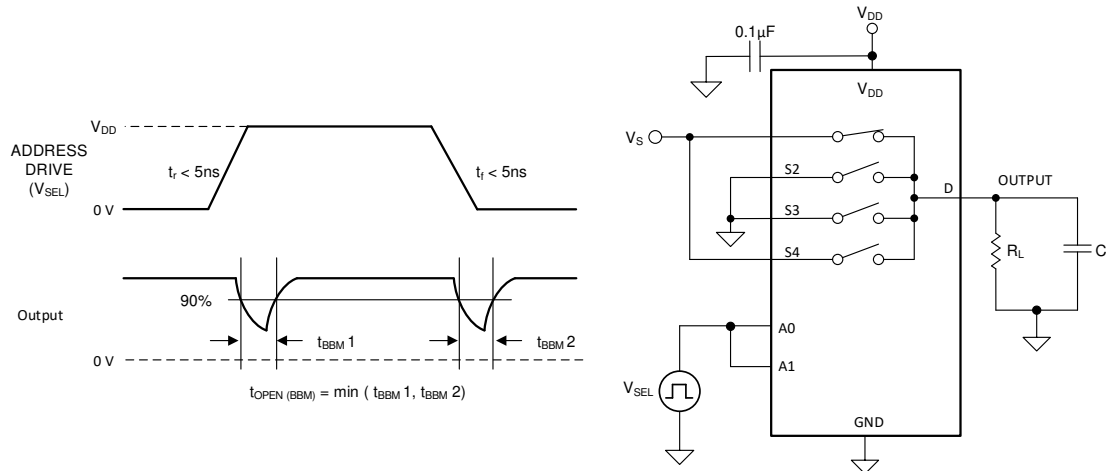


图 11. Break-Before-Make Delay Measurement Setup

## 7.6 $t_{\text{ON(EN)}}$ and $t_{\text{OFF(EN)}}$

Turn-on time is defined as the time taken by the output of the device to rise to 10% after the enable has risen past the logic threshold. The 10% measurement is utilized to provide the timing of the device. System level timing can then account for the time constant added from the load resistance and load capacitance. 图 12 shows the setup used to measure turn-on time, denoted by the symbol  $t_{\text{ON(EN)}}$ .

Turn-off time is defined as the time taken by the output of the device to fall to 90% after the enable has fallen past the logic threshold. The 90% measurement is utilized to provide the timing of the device. System level timing can then account for the time constant added from the load resistance and load capacitance. 图 12 shows the setup used to measure turn-off time, denoted by the symbol  $t_{\text{OFF(EN)}}$ .

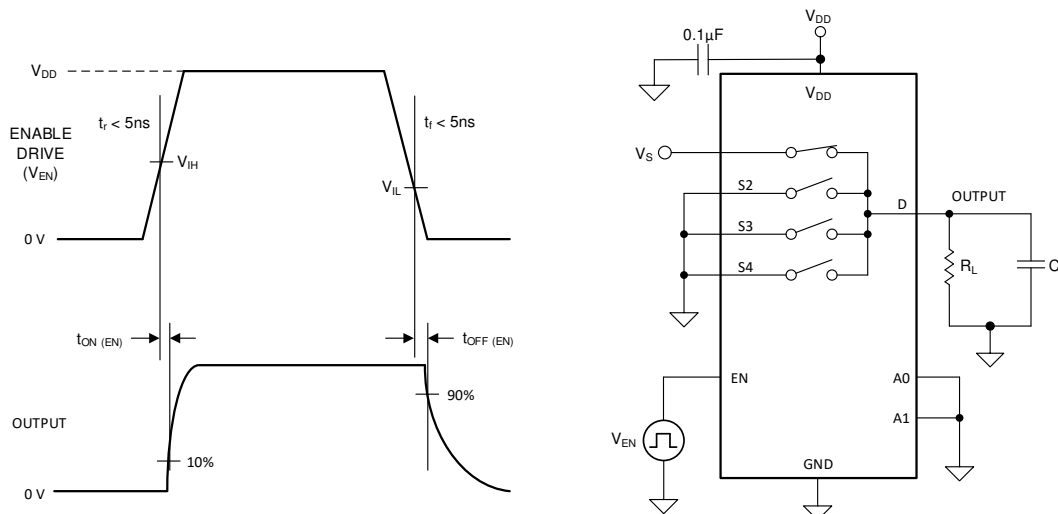


图 12. Turn-On and Turn-Off Time Measurement Setup



## 7.7 Charge Injection

The TMUX1204 has a transmission-gate topology. Any mismatch in capacitance between the NMOS and PMOS transistors results in a charge injected into the drain or source during the falling or rising edge of the gate signal. The amount of charge injected into the source or drain of the device is known as charge injection, and is denoted by the symbol  $Q_C$ . 图 13 shows the setup used to measure charge injection from source ( $S_x$ ) to drain ( $D$ ).

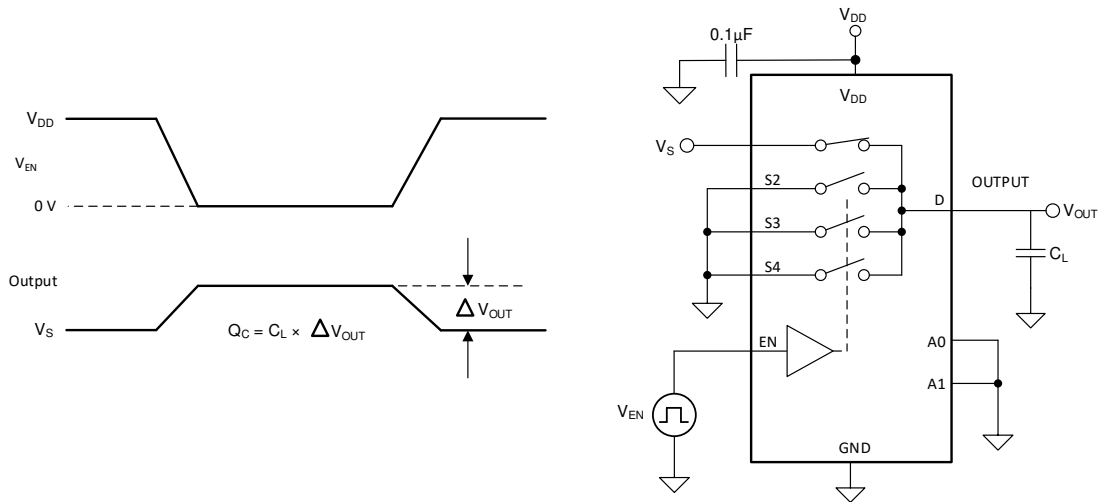


图 13. Charge-Injection Measurement Setup

## 7.8 Off Isolation

Off isolation is defined as the ratio of the signal at the drain pin ( $D$ ) of the device when a signal is applied to the source pin ( $S_x$ ) of an off-channel. 图 14 shows the setup used to measure, and the equation used to calculate off isolation.

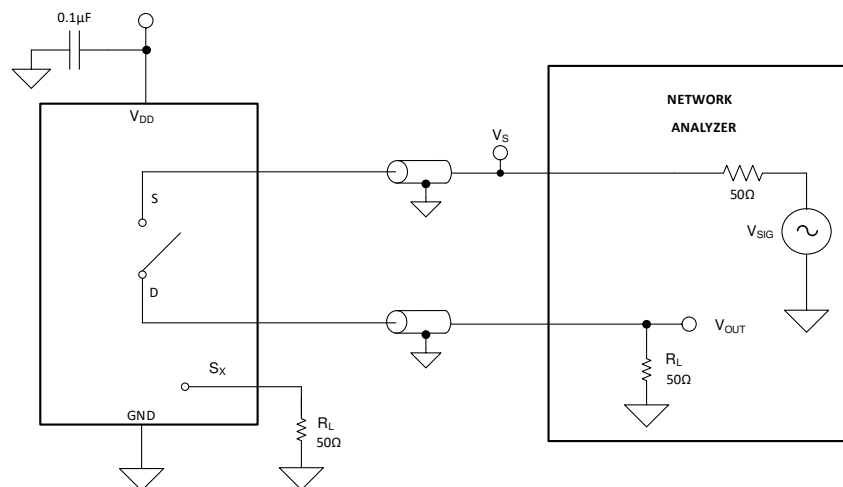


图 14. Off Isolation Measurement Setup

$$\text{Off Isolation} = 20 \cdot \text{Log} \left( \frac{V_{\text{OUT}}}{V_S} \right)$$

(1)

## 7.9 Crosstalk

Crosstalk is defined as the ratio of the signal at the drain pin (D) of a different channel, when a signal is applied at the source pin (Sx) of an on-channel. 图 15 shows the setup used to measure, and the equation used to calculate crosstalk.

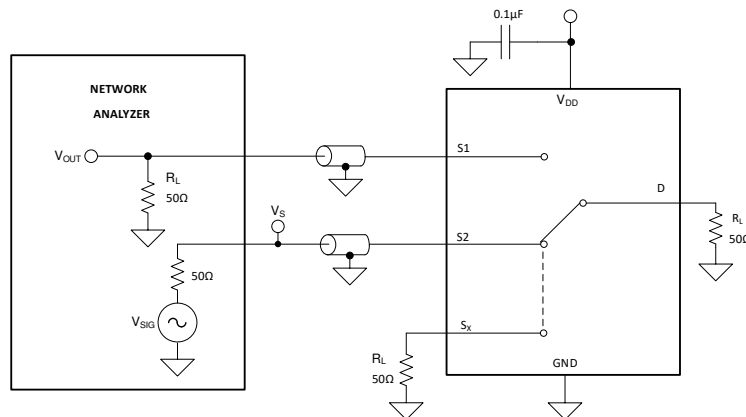


图 15. Crosstalk Measurement Setup

$$\text{Channel-to-Channel Crosstalk} = 20 \cdot \text{Log} \left( \frac{V_{\text{OUT}}}{V_S} \right) \quad (2)$$

## 7.10 Bandwidth

Bandwidth is defined as the range of frequencies that are attenuated by less than 3 dB when the input is applied to the source pin (Sx) of an on-channel, and the output is measured at the drain pin (D) of the device. 图 16 shows the setup used to measure bandwidth.

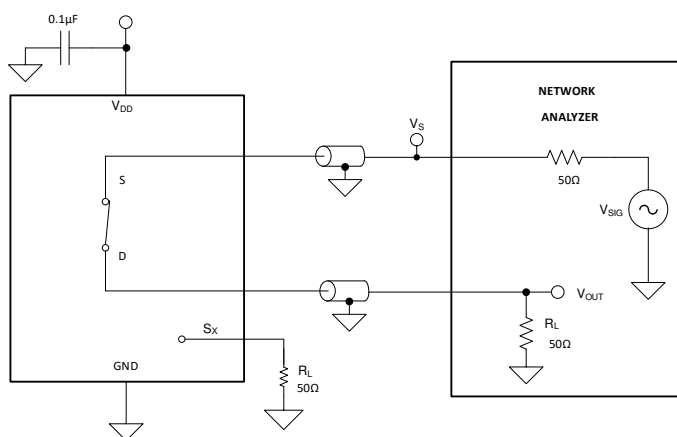


图 16. Bandwidth Measurement Setup

## 8 Detailed Description

### 8.1 Functional Block Diagram

The TMUX1204 is a 4:1, single-ended (1-ch.), mux. Each channel is turned on or turned off based on the state of the address lines and the enable pin.

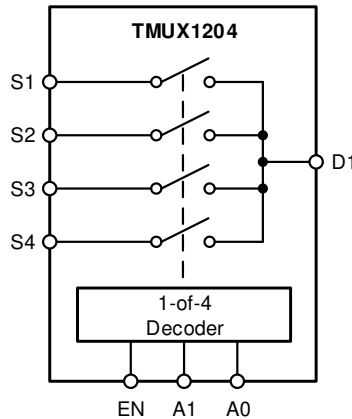


图 17. TMUX1204 Functional Block Diagrams

### 8.2 Feature Description

#### 8.2.1 Bidirectional Operation

The TMUX1204 conducts equally well from source (Sx) to drain (D) or from drain (D) to source (Sx). Each channel has very similar characteristics in both directions and supports both analog and digital signals.

#### 8.2.2 Rail to Rail Operation

The valid signal path input/output voltage for TMUX1204 ranges from GND to  $V_{DD}$ .

#### 8.2.3 1.8 V Logic Compatible Inputs

The TMUX1204 has 1.8-V logic compatible control for all logic control inputs. The logic input thresholds scale with supply but still provide 1.8-V logic control when operating at 5.5 V supply voltage. 1.8-V logic level inputs allows the TMUX1204 to interface with processors that have lower logic I/O rails and eliminates the need for an external translator, which saves both space and BOM cost. For more information on 1.8 V logic implementations refer to [Simplifying Design with 1.8 V logic Muxes and Switches](#)

#### 8.2.4 Fail-Safe Logic

The TMUX1204 supports Fail-Safe Logic on the control input pins (EN, A0, A1) allowing for operation up to 5.5 V, regardless of the state of the supply pin. This feature allows voltages on the control pins to be applied before the supply pin, protecting the device from potential damage. Fail-Safe Logic minimizes system complexity by removing the need for power supply sequencing on the logic control pins. For example, the Fail-Safe Logic feature allows the select pins of the TMUX1204 to be ramped to 5.5 V while  $V_{DD} = 0$  V. Additionally, the feature enables operation of the TMUX1204 with  $V_{DD} = 1.2$  V while allowing the select pins to interface with a logic level of another device up to 5.5 V.

### 8.3 Device Functional Modes

When the EN pin of the TMUX1204 is pulled high, one of the switches is closed based on the state of the address lines. When the EN pin is pulled low, all the switches are in an open state irrespective of the state of the address lines. The EN pin can be connected to  $V_{DD}$  (as high as 5.5 V).

The TMUX1204 can be operated without any external components except for the supply decoupling capacitors. Unused logic control pins should be tied to GND or  $V_{DD}$  in order to ensure the device does not consume additional current as highlighted in [Implications of Slow or Floating CMOS Inputs](#). Unused signal path inputs (Sx or D) should be connected to GND.

### 8.4 Truth Tables

and 表 1 show the truth tables for the TMUX1204, respectively.

表 1. TMUX1204 Truth Table

EN	A1	A0	Selected Channel Connected To Drain (D) Pin
0	X <sup>(1)</sup>	X <sup>(1)</sup>	All channels are off
1	0	0	Channel S1
1	0	1	Channel S2
1	1	0	Channel S3
1	1	1	Channel S4

(1) X denotes *don't care*.

## 9 Application and Implementation

### 注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 9.1 Application Information

The TMUX12xx family offers good system performance across a wide operating supply (1.08V to 5.5V). These devices include 1.8V logic compatible control input pins that enable operation in systems with 1.8V I/O rails. Additionally, the control input pins support Fail-Safe Logic which allows for operation up to 5.5V, regardless of the state of the supply pin. This protection stops the logic pins from back-powering the supply rail. These features make the TMUX12xx a family of general purpose multiplexers and switches that can reduce system complexity, board size, and overall system cost.

### 9.2 Typical Application

One useful application to take advantage of the TMUX1204 features is multiplexing various signals into an ADC that is integrated into a MCU. Utilizing an integrated ADC in a MCU allows a system to minimize cost with a potential tradeoff of system performance when compared to an external ADC. The multiplexer allows for multiple inputs/sensors to be monitored with a single ADC pin of the device, which is critical in systems with limited I/O.

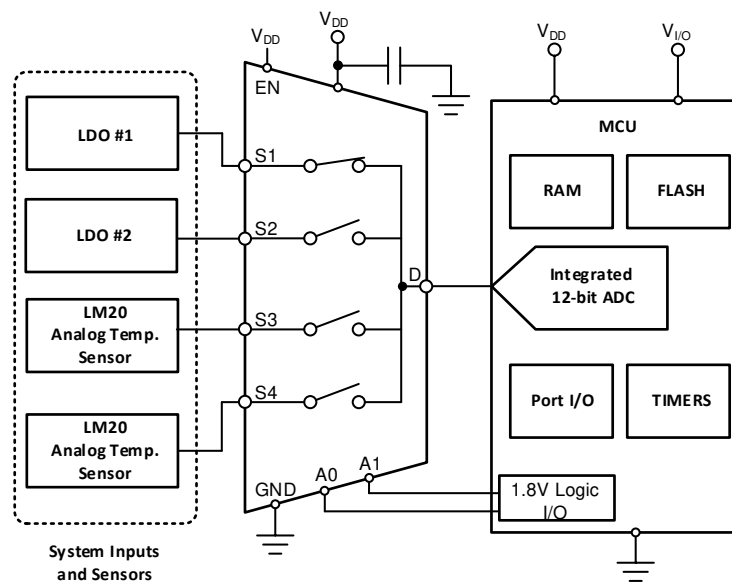


图 18. Multiplexing Signals to Integrated ADC

### 9.3 Design Requirements

For this design example, use the parameters listed in 表 2.

表 2. Design Parameters

PARAMETERS	VALUES
Supply ( $V_{DD}$ )	5.0 V
I/O signal range	0 V to $V_{DD}$ (Rail to Rail)
Control logic thresholds	1.8 V compatible

## 9.4 Detailed Design Procedure

The TMUX1204 can be operated without any external components except for the supply decoupling capacitors. If the parts desired power-up state is disabled, the enable pin should have a weak pull-down resistor and be controlled by the MCU via GPIO. All inputs being muxed to the ADC of the MCU must fall within the recommend operating conditions of the TMUX1204 including signal range and continuous current. For this design with a supply of 5 V the signal range can be 0 V to 5 V and the max continuous current can be 30 mA.

## 9.5 Application Curve

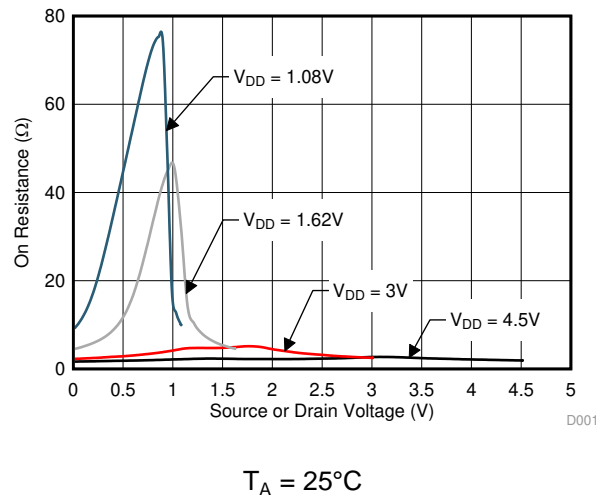


图 19. On-Resistance vs Source or Drain Voltage

## 10 Power Supply Recommendations

The TMUX1204 operates across a wide supply range of 1.08 V to 5.5 V. Do not exceed the absolute maximum ratings because stresses beyond the listed ratings can cause permanent damage to the devices.

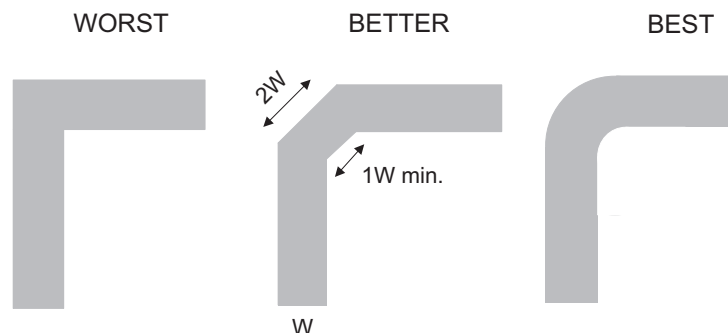
Power-supply bypassing improves noise margin and prevents switching noise propagation from the  $V_{DD}$  supply to other components. Good power-supply decoupling is important to achieve optimum performance. For improved supply noise immunity, use a supply decoupling capacitor ranging from 0.1  $\mu\text{F}$  to 10  $\mu\text{F}$  from  $V_{DD}$  to ground. Place the bypass capacitors as close to the power supply pins of the device as possible using low-impedance connections. TI recommends using multi-layer ceramic chip capacitors (MLCCs) that offer low equivalent series resistance (ESR) and inductance (ESL) characteristics for power-supply decoupling purposes. For very sensitive systems, or for systems in harsh noise environments, avoiding the use of vias for connecting the capacitors to the device pins may offer superior noise immunity. The use of multiple vias in parallel lowers the overall inductance and is beneficial for connections to ground planes.

## 11 Layout

### 11.1 Layout Guidelines

#### 11.1.1 Layout Information

When a PCB trace turns a corner at a 90° angle, a reflection can occur. A reflection occurs primarily because of the change of width of the trace. At the apex of the turn, the trace width increases to 1.414 times the width. This increase upsets the transmission-line characteristics, especially the distributed capacitance and self-inductance of the trace which results in the reflection. Not all PCB traces can be straight and therefore some traces must turn corners. [图 20](#) shows progressively better techniques of rounding corners. Only the last example (BEST) maintains constant trace width and minimizes reflections.



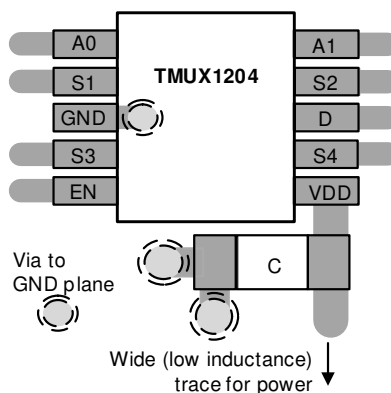
**图 20. Trace Example**

Route high-speed signals using a minimum of vias and corners which reduces signal reflections and impedance changes. When a via must be used, increase the clearance size around it to minimize its capacitance. Each via introduces discontinuities in the signal's transmission line and increases the chance of picking up interference from the other layers of the board. Be careful when designing test points, through-hole pins are not recommended at high frequencies.

[图 21](#) illustrates an example of a PCB layout with the TMUX1204. Some key considerations are:

- Decouple the  $V_{DD}$  pin with a 0.1- $\mu$ F capacitor, placed as close to the pin as possible. Make sure that the capacitor voltage rating is sufficient for the  $V_{DD}$  supply.
- Keep the input lines as short as possible.
- Use a solid ground plane to help reduce electromagnetic interference (EMI) noise pickup.
- Do not run sensitive analog traces in parallel with digital traces. Avoid crossing digital and analog traces if possible, and only make perpendicular crossings when necessary.

### 11.2 Layout Example



**图 21. TMUX1204 Layout Example**

## 12 器件和文档支持

### 12.1 文档支持

#### 12.1.1 相关文档

德州仪器 (TI), 《[使用 1.8V 逻辑多路复用器和开关简化设计](#)》。

德州仪器 (TI), 《[QFN/SON PCB 连接](#)》。

德州仪器 (TI), 《[四方扁平封装无引线逻辑封装](#)》。

### 12.2 接收文档更新通知

要接收文档更新通知, 请导航至 [ti.com](http://ti.com) 上的器件产品文件夹。单击右上角的通知我进行注册, 即可每周接收产品信息更改摘要。有关更改的详细信息, 请查看任何已修订文档中包含的修订历史记录。

### 12.3 社区资源

[TI E2E™ support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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ESD 的损坏小至导致微小的性能降级, 大至整个器件故障。精密的集成电路可能更容易受到损坏, 这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

### 12.6 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

## 13 机械、封装和可订购信息

以下页面包含机械、封装和可订购信息。这些信息是指定器件的最新可用数据。数据如有变更, 恕不另行通知, 且不会对此文档进行修订。如需获取此数据表的浏览器版本, 请查阅左侧的导航栏。



## PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package   Pins	Package qty   Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
<a href="#">TMUX1204DGSR</a>	Active	Production	VSSOP (DGS)   10	2500   LARGE T&R	Yes	NIPDAUAG   SN	Level-1-260C-UNLIM	-40 to 125	1F6
TMUX1204DGSR.A	Active	Production	VSSOP (DGS)   10	2500   LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1F6
<a href="#">TMUX1204DQAR</a>	Active	Production	USON (DQA)   10	3000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	204
TMUX1204DQAR.A	Active	Production	USON (DQA)   10	3000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	204
TMUX1204DQARG4.A	Active	Production	USON (DQA)   10	3000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	204

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

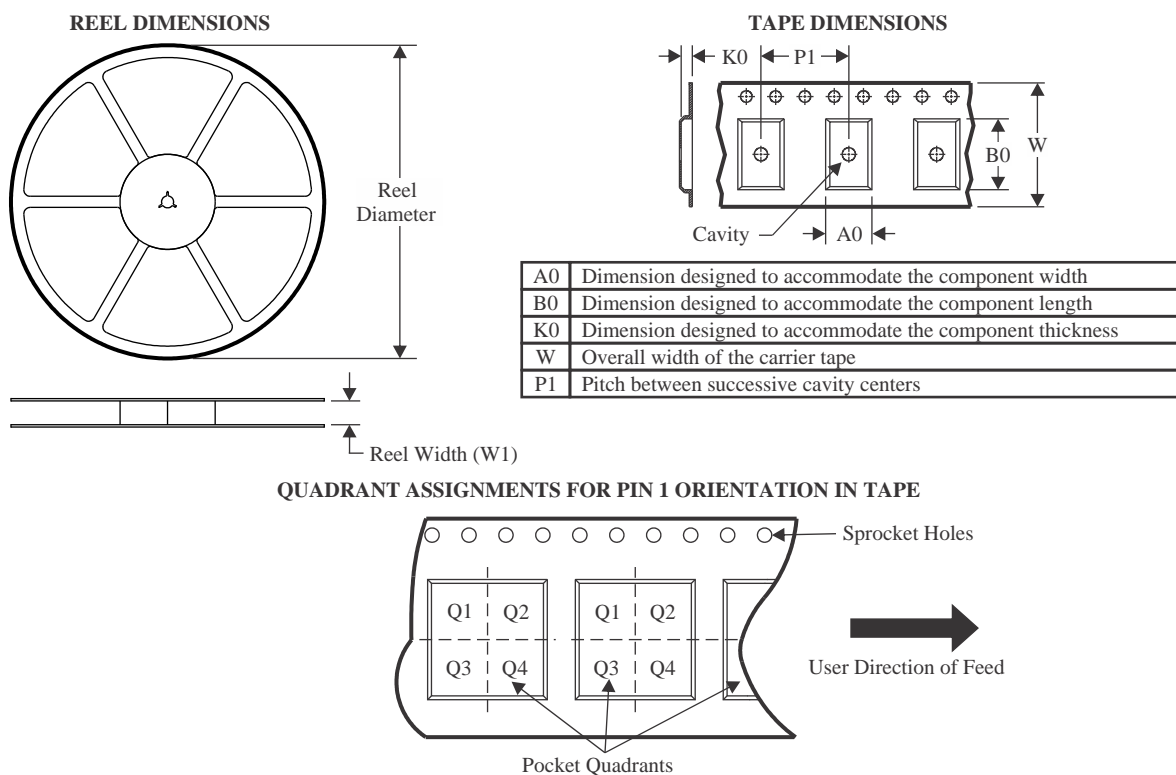
<sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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## TAPE AND REEL INFORMATION



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TMUX1204DGSR	VSSOP	DGS	10	2500	330.0	12.4	5.25	3.35	1.25	8.0	12.0	Q1
TMUX1204DQAR	USON	DQA	10	3000	180.0	9.5	1.18	2.68	0.72	4.0	8.0	Q1

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TMUX1204DGSR	VSSOP	DGS	10	2500	366.0	364.0	50.0
TMUX1204DQAR	USON	DQA	10	3000	189.0	185.0	36.0



# EXAMPLE BOARD LAYOUT

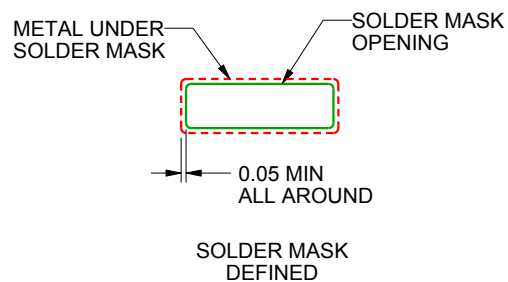
DGS0010A

VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE  
SCALE:10X



SOLDER MASK DETAILS  
NOT TO SCALE

4221984/A 05/2015

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

## EXAMPLE STENCIL DESIGN

DGS0010A

VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE:10X

4221984/A 05/2015

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

## GENERIC PACKAGE VIEW

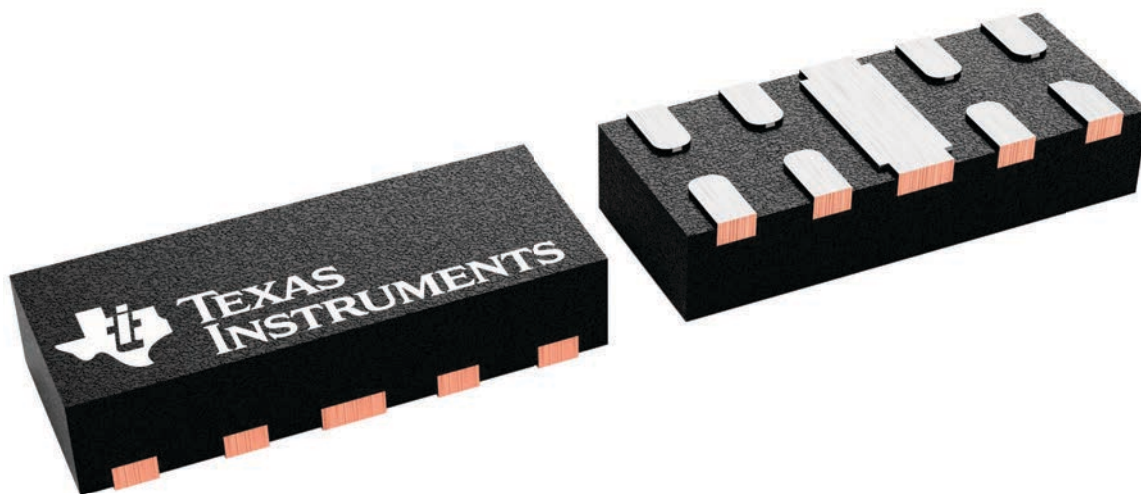
**DQA 10**

**USON - 0.55 mm max height**

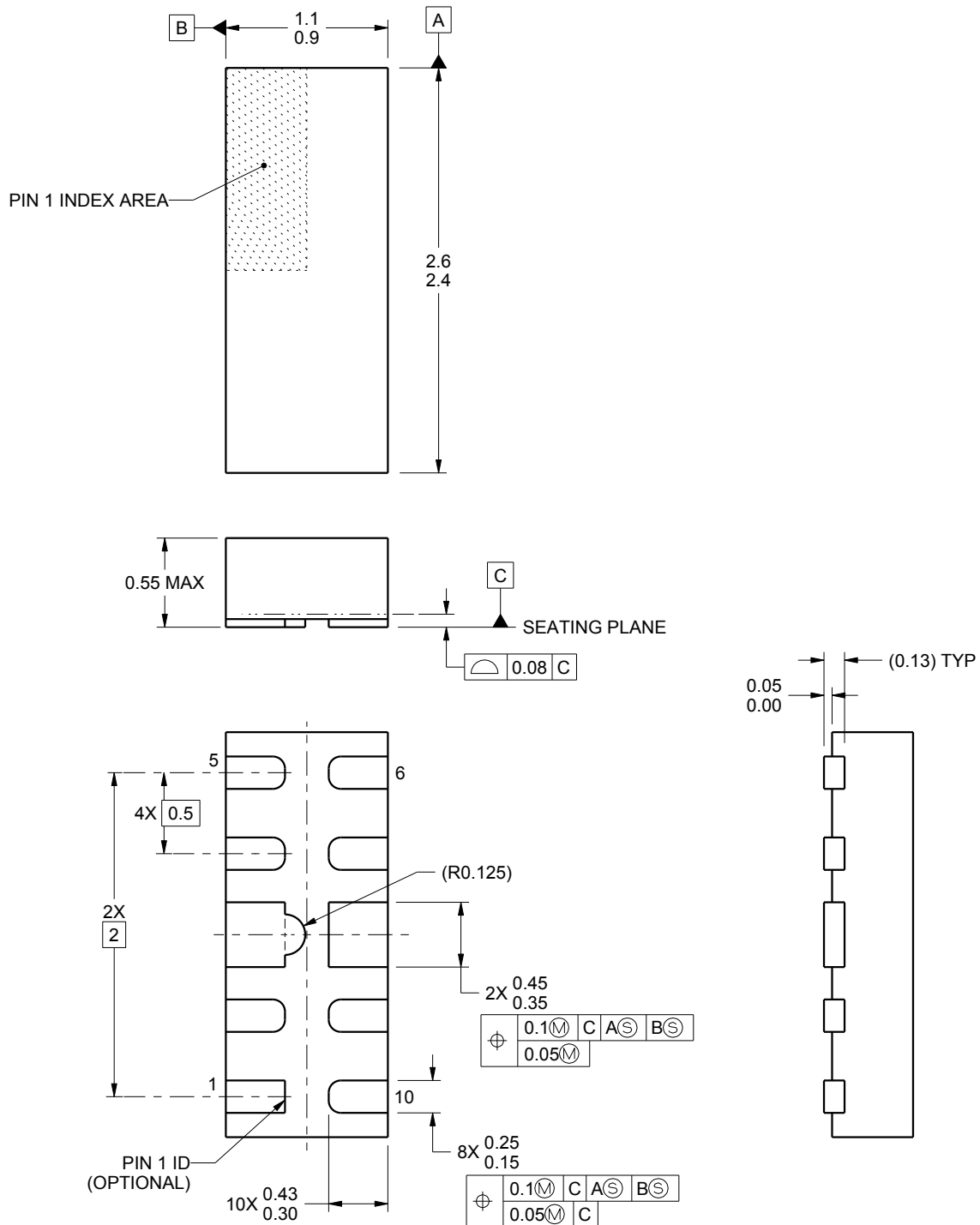
1 x 2.5, 0.5 mm pitch

PLASTIC SMALL OUTLINE - NO LEAD

This image is a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.



4230320/A



4220328/A 12/2015

## NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.

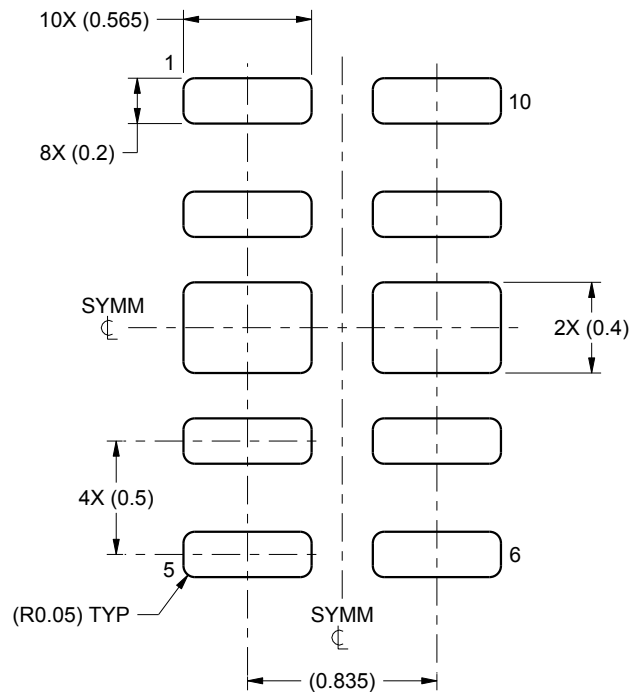


# EXAMPLE BOARD LAYOUT

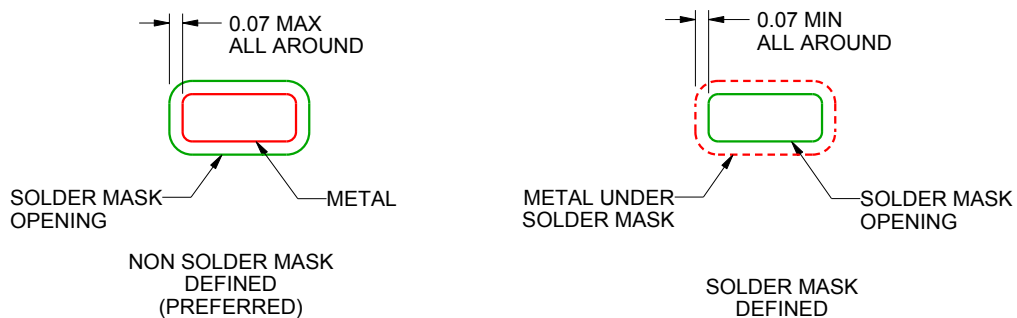
DQA0010A

USON - 0.55 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



LAND PATTERN EXAMPLE  
SCALE:30X



SOLDER MASK DETAILS

4220328/A 12/2015

NOTES: (continued)

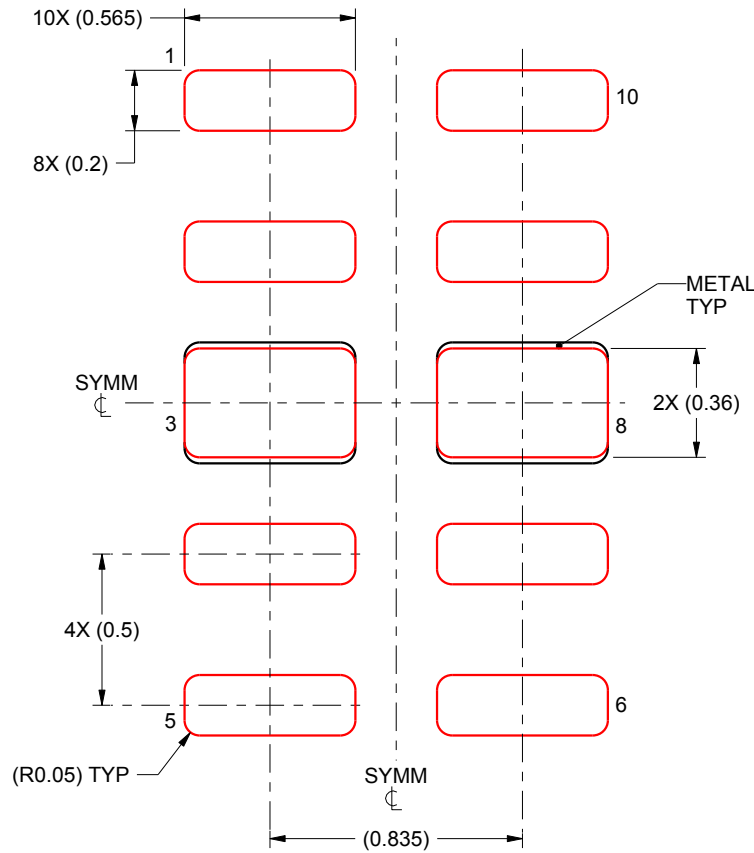
3. For more information, see Texas Instruments literature number SLUA271 ([www.ti.com/lit/slua271](http://www.ti.com/lit/slua271)).

# EXAMPLE STENCIL DESIGN

DQA0010A

USON - 0.55 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



SOLDER PASTE EXAMPLE  
BASED ON 0.1 mm THICK STENCIL

EXPOSED PADS 3 & 8:  
90% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE  
SCALE:40X

4220328/A 12/2015

NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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最后更新日期：2025 年 10 月